Erratum: “Magnetic nanowire based high resolution magnetic force microscope probes” [Appl. Phys. Lett. 87, 123507 (2005)]

G. Yang
Department of Physics and Astronomy, University of North Carolina, Chapel Hill, North Carolina 27599

J. Tang and S. Kato
National Institute for Materials Science, Tsukuba 305-0047, Japan

Q. Zhang and L. C. Qin
Department of Physics and Astronomy and Curriculum in Applied and Materials Sciences,
University of North Carolina, Chapel Hill, North Carolina 27599

M. Woodson and J. Liu
Department of Chemistry, Duke University, Durham, North Carolina 27708

J. W. Kim
Science and Technology Corp., Hampton, Virginia 23666

P. T. Lillehei
Advanced Materials and Processing Branch, MS-226 NASA Langley Research Center, Hampton,
Virginia 23681

C. Park
National Institute of Aerospace, MS-226 NASA Langley Research Center, Hampton, Virginia 23681

O. Zhou
Department of Physics and Astronomy and Curriculum in Applied and Materials Sciences,
University of North Carolina, Chapel Hill, North Carolina 27599

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The name of one author, P. T. Lillehei, appeared incorrectly due to an input error. The correct names appear above.